



Laboratoria De Nayer v.z.w.
Department of Electronics
Section E.M.C.

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Photo's test setup	
Product	DSRFID type D
LDN Number	LDN5031
Date of issue	2024-09-24
Standard	FCC part 15 subpart C
EMC report	PCC-RAD-6113

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The results refer to the described sample or equipment under test only.
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In case the customer wants to refer to his appeal to our accredited laboratories, he will use the following orequivalent sentence: "Tested by Laboratoria De Nayer, E.M.C.department, accredited by BELAC for EMC-immunity and EMC-emission under registration number 041-TEST".

photo : conducted emission set-up (0.15-30MHz)

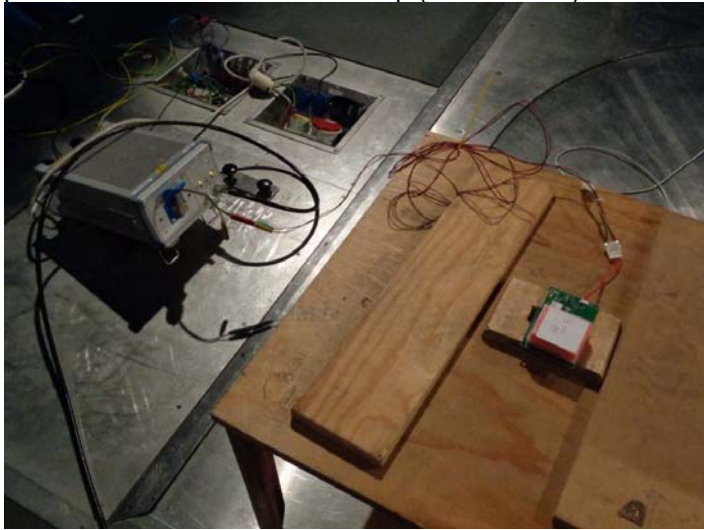


photo 2: radiated emission set-up (9k-30MHz)



Photo : radiates emission (30-50MHz)

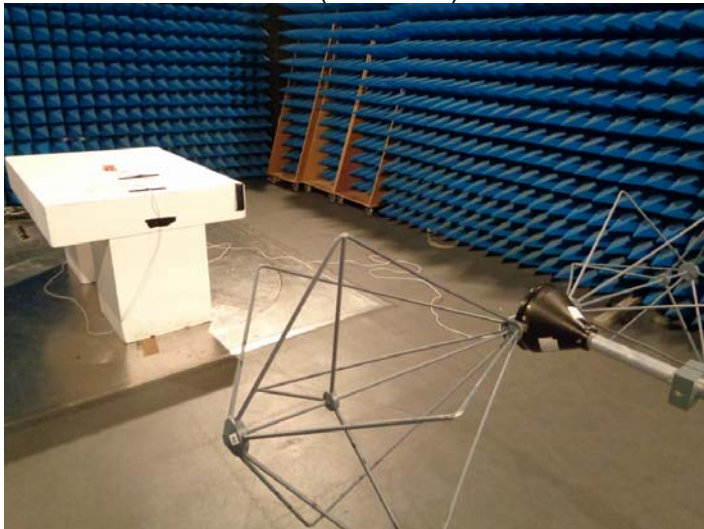


Photo : radiates emission (30-1000MHz)



Photo : EUT in thermal chamber

